FAIRCHILD SEMICONDUCTOR*

FDS7088N7 30V N-Channel PowerTrench[®] MOSFET

General Description

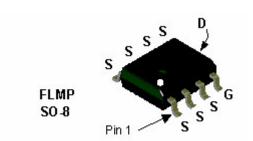
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

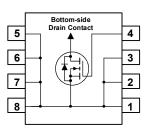
Applications

- Synchronous rectifier
- DC/DC converter

Features

- 23 A, 30 V $R_{DS(ON)} = 3 \text{ m}\Omega \textcircled{0} V_{GS} = 10 \text{ V}$ $R_{DS(ON)} = 4 \text{ m}\Omega \textcircled{0} V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability
- Fast switching
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





Absolute Maximum Ratings T_A=25°C unless otherwise noted

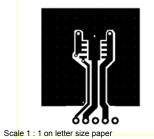
Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Source Voltage			30	
V _{GSS}	Gate-Source Voltage			±20	
I _D	Drain Curre	nt – Continuous	(Note 1a)	23	A
		– Pulsed		60	
PD	Power Diss	ipation for Single Operat	tion (Note 1a)	3.0	W
			(Note 1b)	1.5	
T _J , T _{STG}	Operating a	ating and Storage Junction Temperature Range		–55 to +150	°C
Therma	l Charac	teristics			
R _{0JA}	Thermal Resistance, Junction-to-Ambient (Note 1a)		40		
R _{eJC}	Thermal Resistance, Junction-to-Case (Note 1)			0.5	
Packag	e Markin	g and Ordering	Information		
Device	Marking	Device	Reel Size	Tape width	Quantity
	088N7	FDS7088N7	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			1		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		25		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$, $V_{GS} = 0 V$			10	μA
I _{GSS}	Gate–Body Leakage	V_{GS} = ±20 V, V_{DS} = 0 V			±100	nA
On Chara	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-6		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance			2.4 3.3 3.5	3 4 5.5	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 10 V$, $I_{D} = 23 A$		112		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,		3845		pF
Coss	Output Capacitance	f = 1.0 MHz		930		pF
C _{rss}	Reverse Transfer Capacitance			368		pF
R _G	Gate Resistance	V_{GS} = 15 mV, f = 1.0 MHz		1.4		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 15 V$, $I_D = 1 A$,		15	27	ns
t _r	Turn–On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		13	23	ns
t _{d(off)}	Turn–Off Delay Time			62	99	ns
t _f	Turn–Off Fall Time			36	58	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$, $I_D = 23 A$,		37	48	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 5.0 V		10		nC
Q _{gd}	Gate–Drain Charge			14		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Sourc	e Diode Forward Current			2.5	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 2.5 A$ (Note 2)		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 23 A,		39		nS
Q _{rr}	Diode Reverse Recovery Charge	d _{iF} /dt = 100 A/µs		33		nC

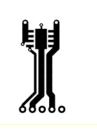
Notes:

1. R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.



2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty Cycle < 2.0 %

a) 40°C/W when mounted on a 1in² pad of 2 oz copper

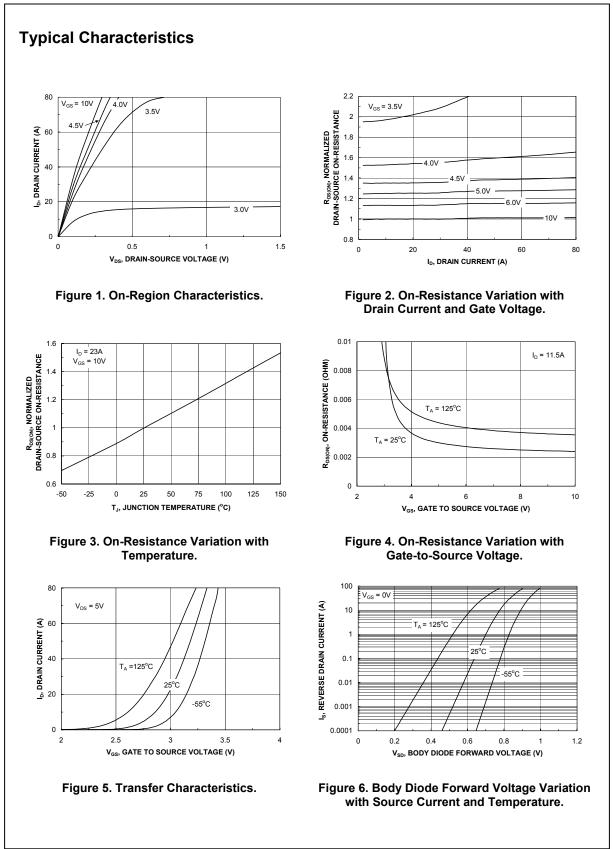


85°C/W when mounted on a minimum pad of 2 oz copper

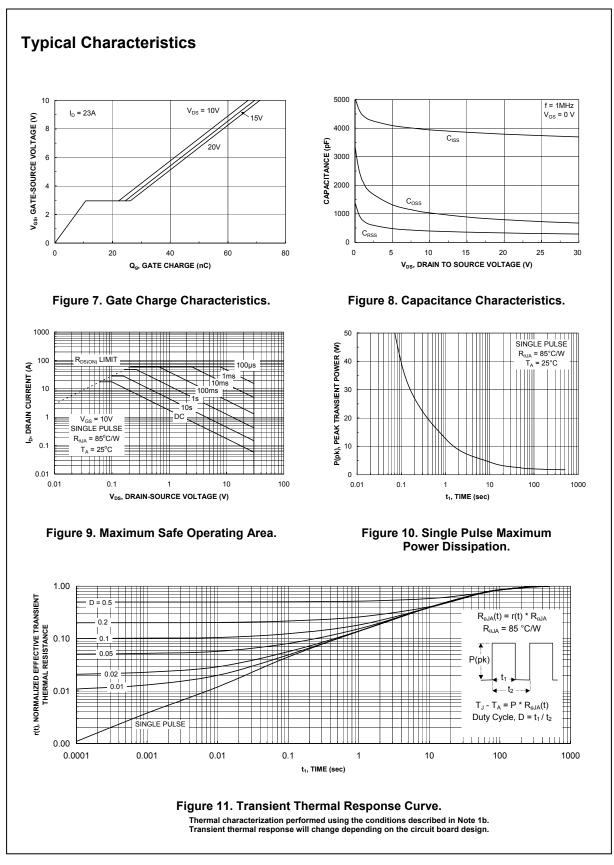
b)

FDS7088N7 Rev D1 (W)

FDS7088N7

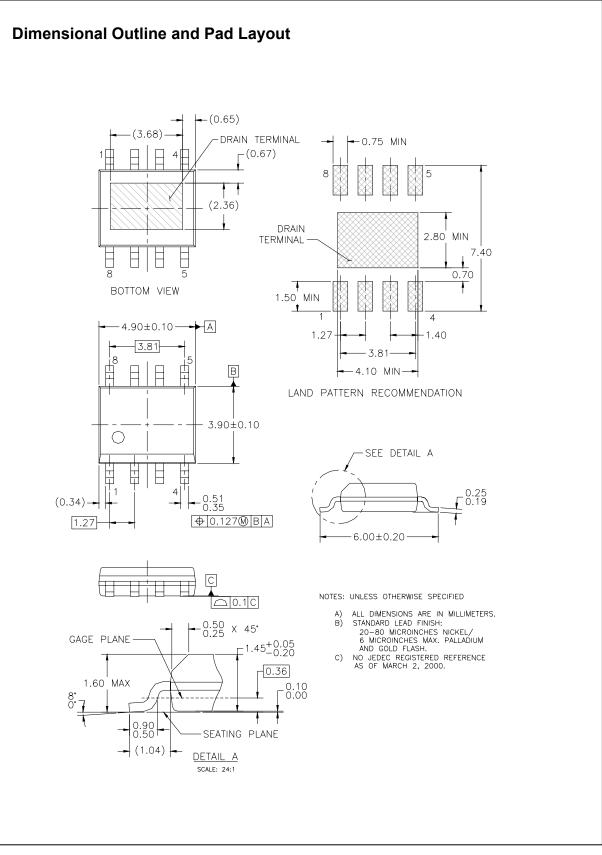


FDS7088N7



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FDS7088N7 Rev D1 (W)



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